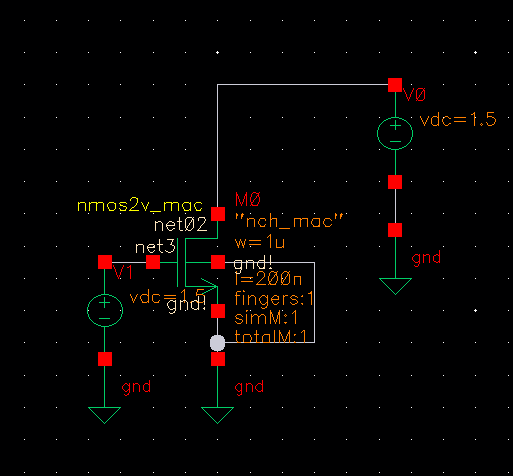
ETICD Lab#1

We have been asked to use simulations to find different parameters of a Nmos transistor and Pmos transistor, and simulate a inverter using Nmos and Pmos transistors.

* Nmos

The Nmos transistor has to follow the following specifications; W/L=1μm/200nm and have a Vdd=1.5V. Below is the schematic of the transistor used in our simulations.



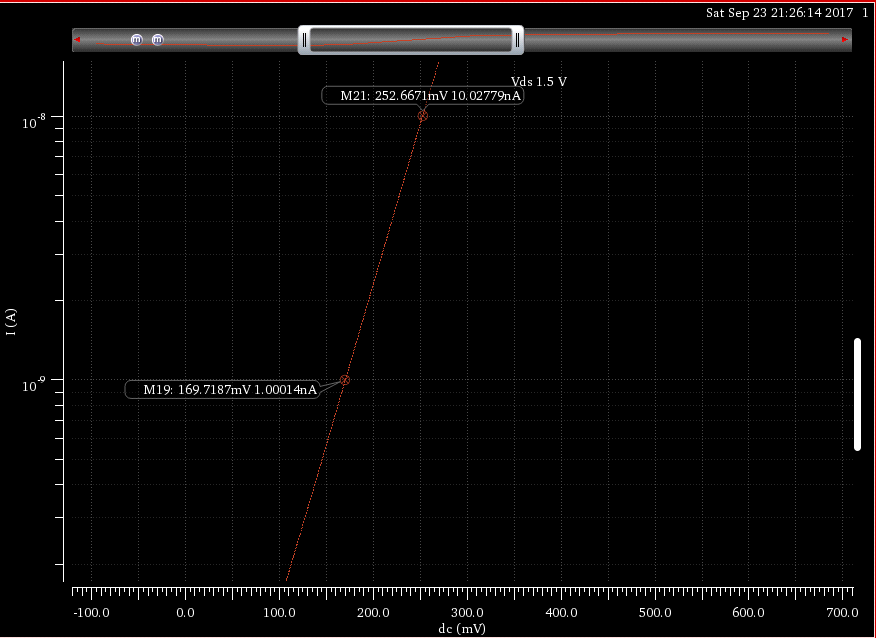
*Figur 1 NMOS test bench schematic*

|  |  |
| --- | --- |
| Threshold Voltage V\_th | 0.6 V |
| Subthreshold swing | 85mV/dec |
| DIBL | 17.1mV |
| Ioff | 11.1pA |
| Channel Length Coefficient | 0.118 |

*Table 1 Table for Nmos values found in simulations.*

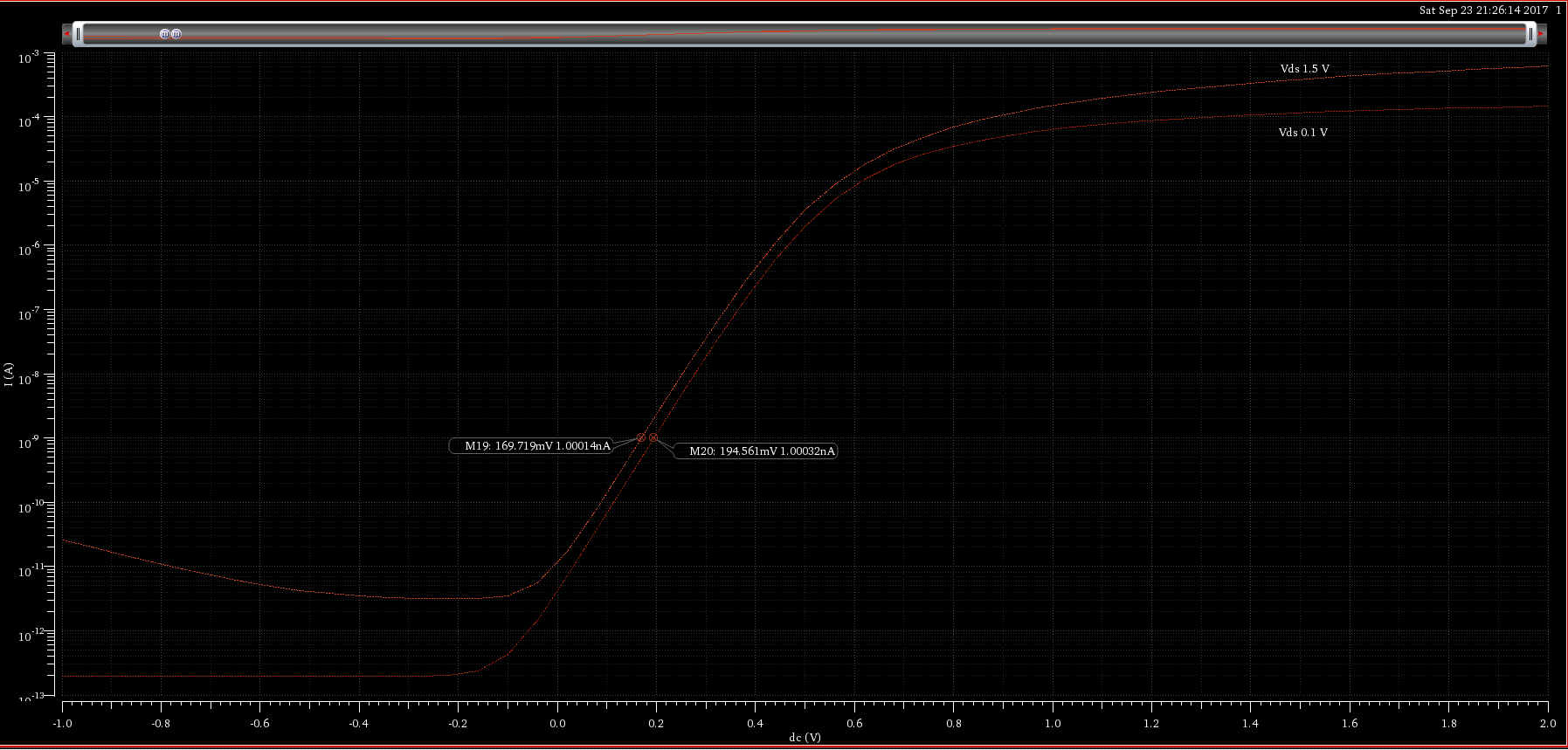
Table 1 shows the values we found in our simulation of a Nmos transistor, the sections after this explain how we found these values and discuss their testbench images.

Subthreshold slope



*Figur 3 Subthreshold slope of the NMOS transistor*

The subthreshold slope is fund be looking at the graph (Figur 2) in the subthreshold region where Vgs < Vth. To find the subthreshold you can measure the voltage difference between two decades. So, for our simulation the subthreshold slope is 252mV-169mV = 83mV/decade. The typical subthreshold at room temperature is around 60mV/decade.

DIBL

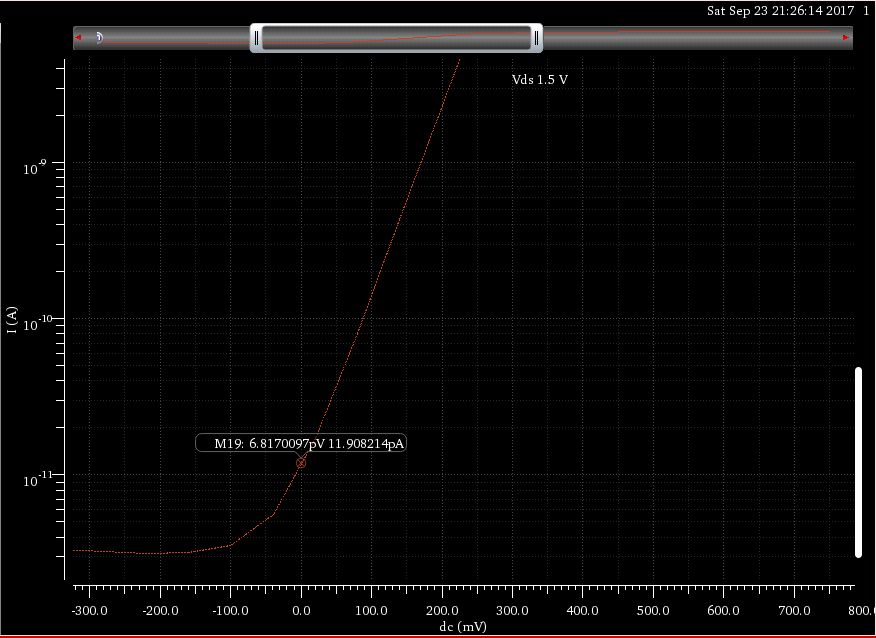
*Figur 4 DIBL of the NMOS transistor with markers for the two threshold voltages*

The DIBL(Drain-Induced Barrier Lowering) increases the drain source voltage leakage in transistors with short channels at low Vds voltage. By lowering the Vds voltage on the transistor and plot sweep on the same graph as your normal Vds. You can find the delta Vth and delta Vds and calculate the DIBL effect be this formula . For our transistor (see Figur 3), the DIBL is

|  |  |  |
| --- | --- | --- |
|  |  |  |

*Ligningen løses for DIBL vha. CAS-værktøjet WordMat.*

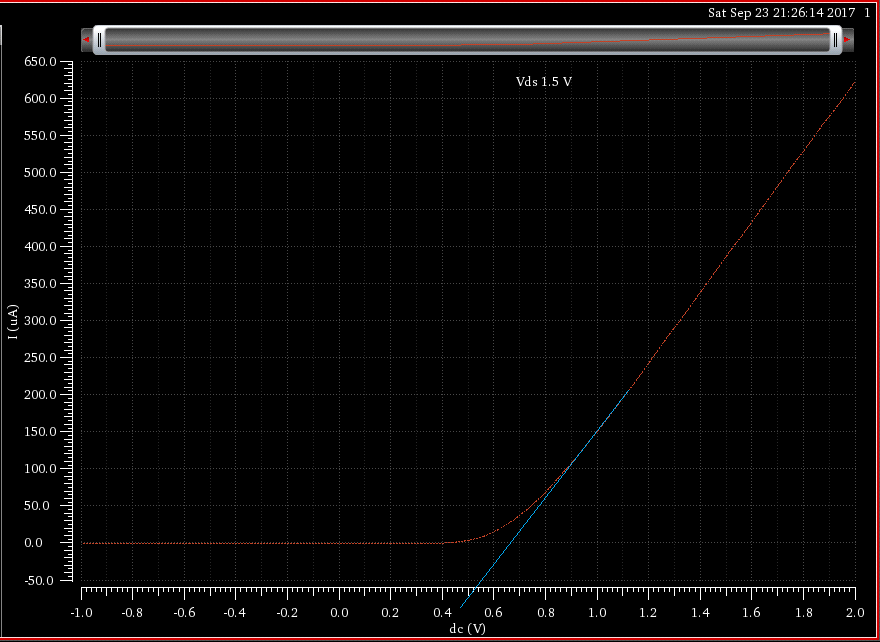
Ioff



*Figur 5 Ioff shown on the graph*

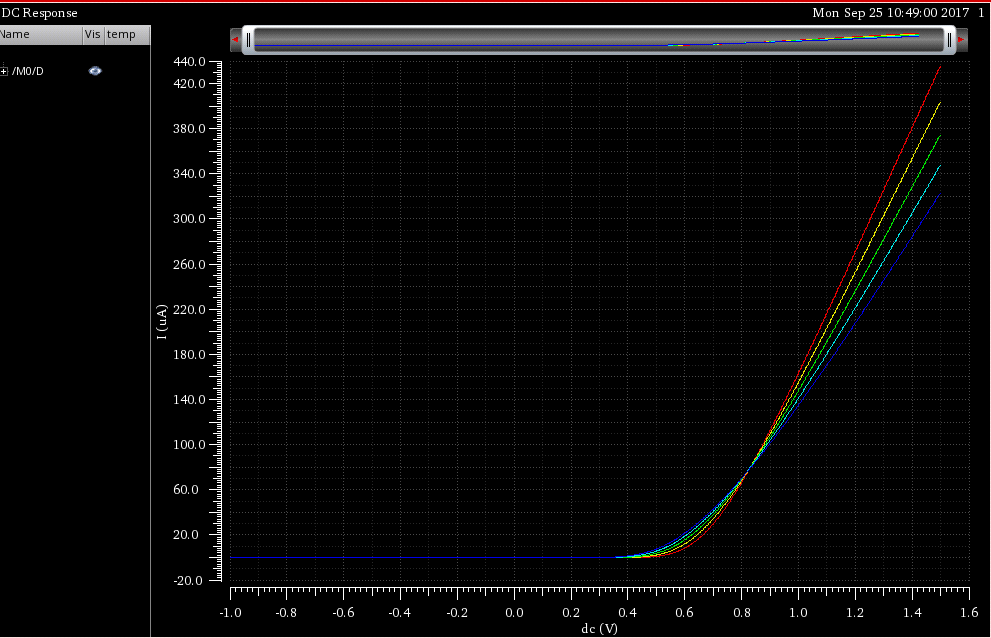
The Ioff is the current leakage from drain to source when the gate voltage is equal to zero and the NMOS transistor is turned off. As seen in Figur 4 the Ioff for our simulated NMOS transistor is ~12pA.

Threshold Voltage



*Figur 6 Threshold voltage of the NMOS transistor*

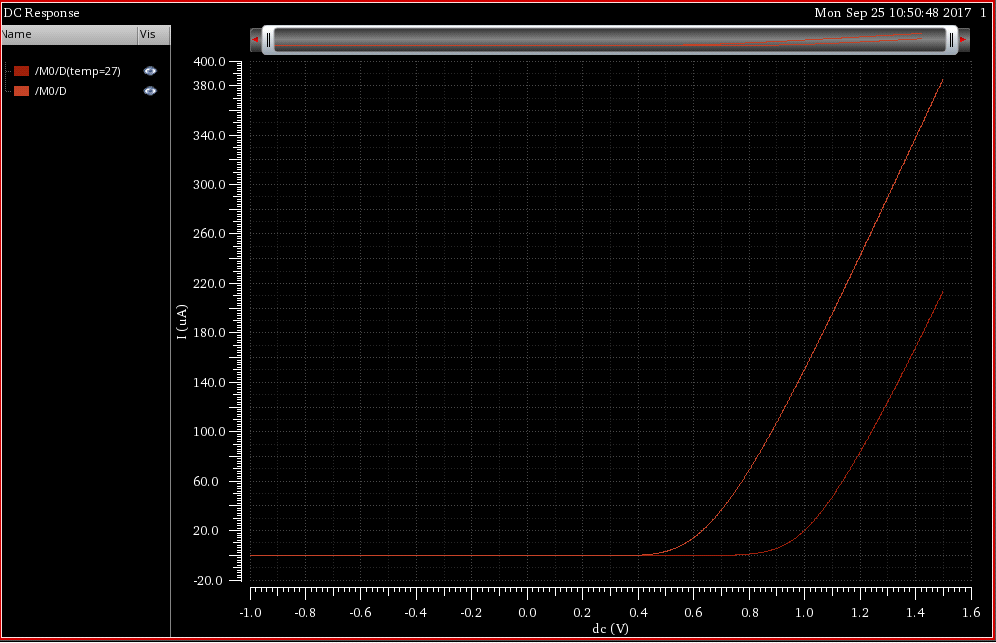
To read a transistor threshold voltage from a linear graph. you draw a line from the straight part of the graph as seen on Figur 5. Where the line crosses the x axis you have your threshold voltage. In our case the Vth is ~539mV.

Temperatur effects

*Figur 7 Temperature effect on a NMOS transistor shown with 5 graphs between -40 and 125 degrees, blue line is at -40 degrees and the red line is at 125 degrees*

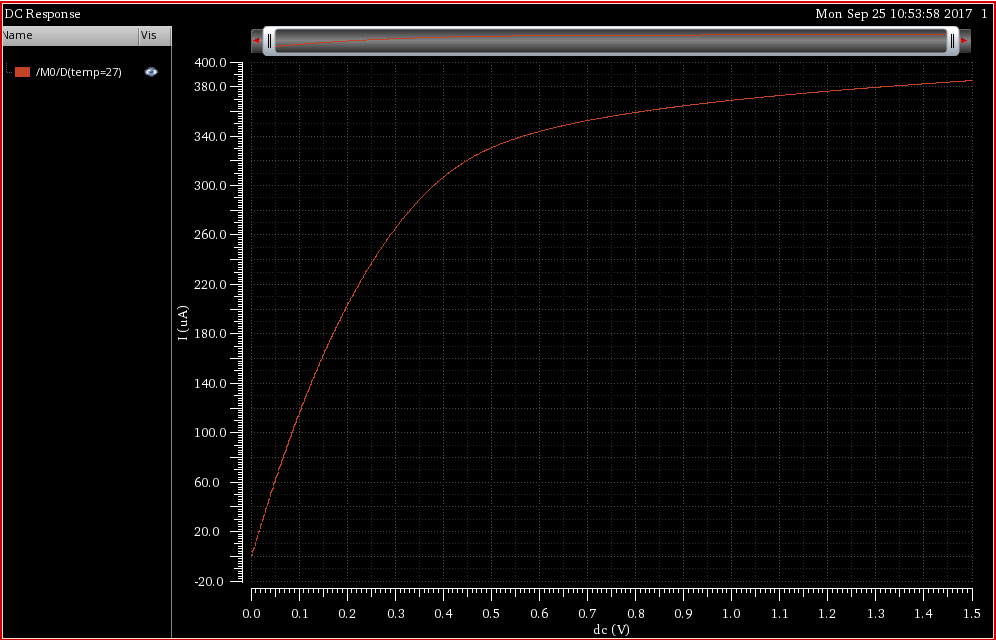
In the temperature sweep of the NMOS transistor with Vgs=0. You can see in the graph on Figur 6 that the Ioff increases when the temperature raises. Also we see that the largest effect the temperature has is in the region around Vt, where the spread is the largest between the temparatures before the saturation region.

Body voltage effect on threshold voltage



*Figur 8 Threshold voltage increased after the Body is connected to Vdd instead of gnd*

By increasing the body voltage we can manipulate the threshold voltage of the transistor. As seen in Figur 9 the threshold voltage is increased to 860mVcompared to the ~560 we had before, when the bulk gate is connected to Vdd instead of gnd.

Channel length modulation coefficient

*Figur 9 Graph of the Nmos transistors Ids-Vds characteristics*

To find the Channel length modulation coefficient we follow the equation I\_dsat/R\_on, both of these can be found on the graph. I\_dsat is the current when the transistor enters the saturation region, read as the current when the voltage is at Vt. R\_on is the slope of the linear region after the transistor enters the saturation region. Reading the graph and substituting into our equation we get a Channel length modulation coefficient of: 0.118

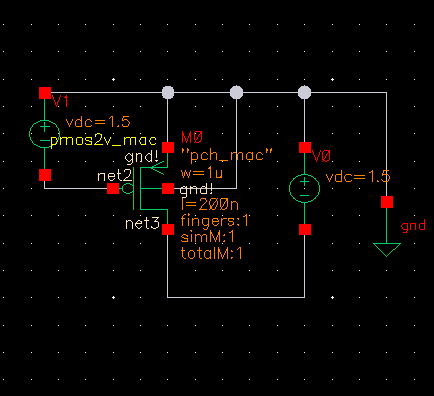
* Pmos

The Pmos transistor follows the specificationsas the Nmos; W/L=1μm/200nm and have a Vdd=1.5V. Below is the schematic of the transistor used in our simulations. for many of the parameters, the same method used for a Nmos transistor applies to the Pmos transistor as well, in these cases we will simply write the final equation or value, while refering to the Nmos section for explanations. Below is a table showing the values we have found, after that are more indepth explanations and testbench images of these values.

PMOS

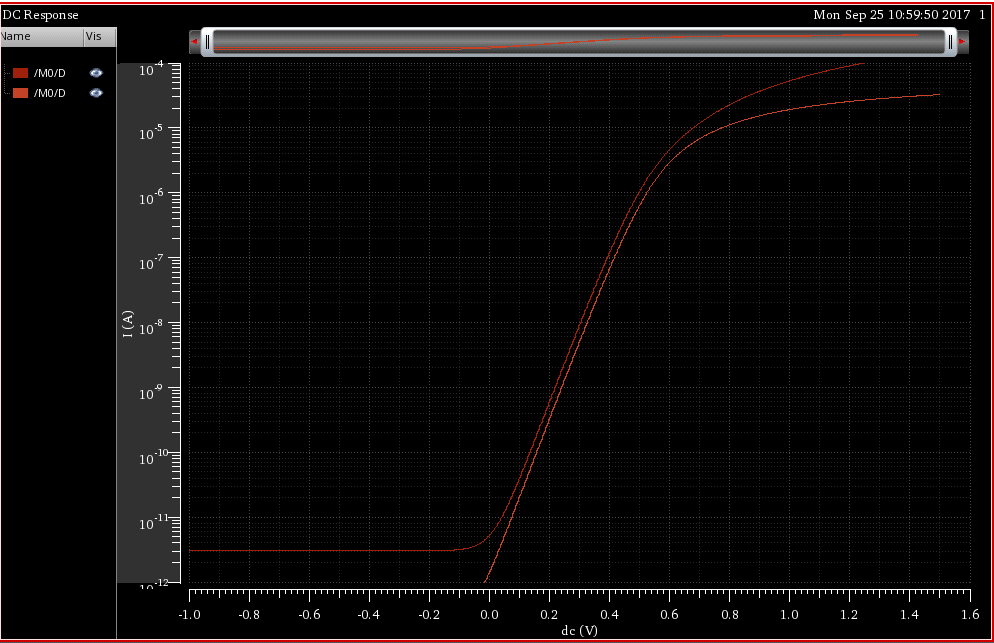
|  |  |
| --- | --- |
| Threshold Voltage V\_th | 0.49 V |
| Subthreshold swing | 90mV/Dec |
| DIBL | 16.9mV |
| Ioff | -5.33pA |
| Channel Length Coefficient | 0.218 |

*Table 2 Values found for Pmos through simulations.*



*Figur 10 Schematic of the Pmos transistor*

Subthreshold slope



*Figur 11 Subthreshold slope of the PMOS transistor*

The subthreshold slope of the Pmos is(see Nmos scetion for definition): 90mV/Dec

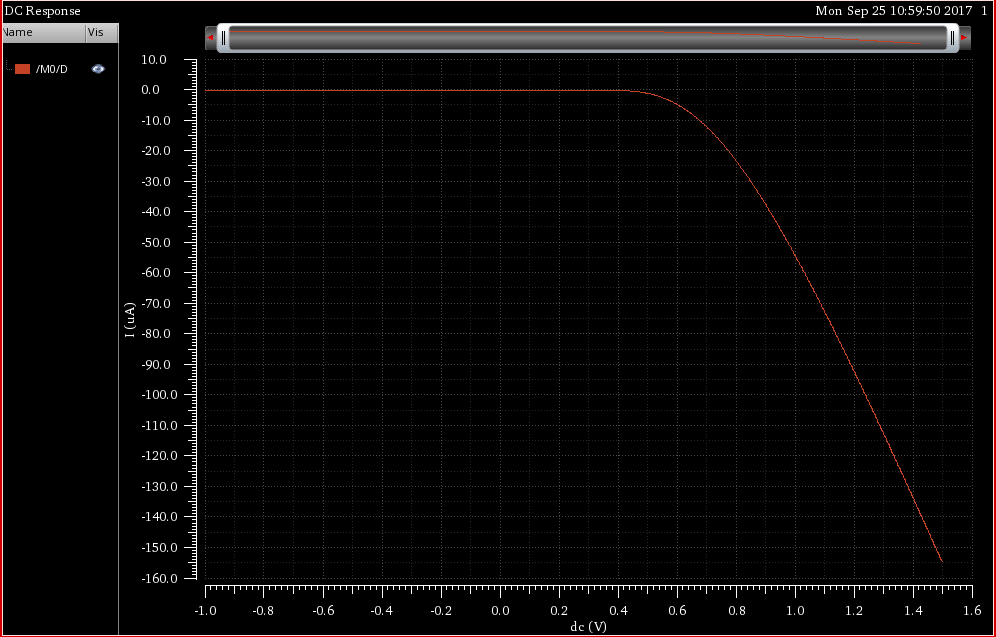
DIBL

The DIBL(Drain-Induced Barrier Lowering) of the Pmos is(see Nmos scetion for definition):: 16.9mV

Ioff

The Ioff current of the Pmos is(see Nmos scetion for definition): -5.33pA

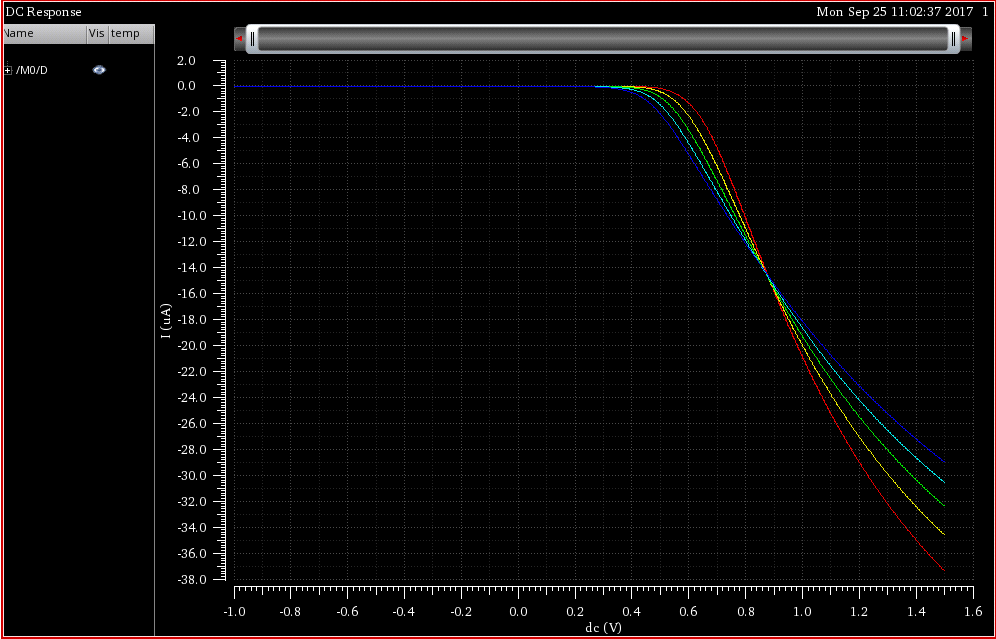
Threshold Voltage



*Figur 12 Threshold voltage of the PMOS transistor*

reading the threshold voltage is a bit different for the Pmos graph, here you need to find the point the graph enters the saturation region, or more specifik where the graph becomes linear and read the voltage value at this point. We read the Threshold voltage to be: 0.49 V

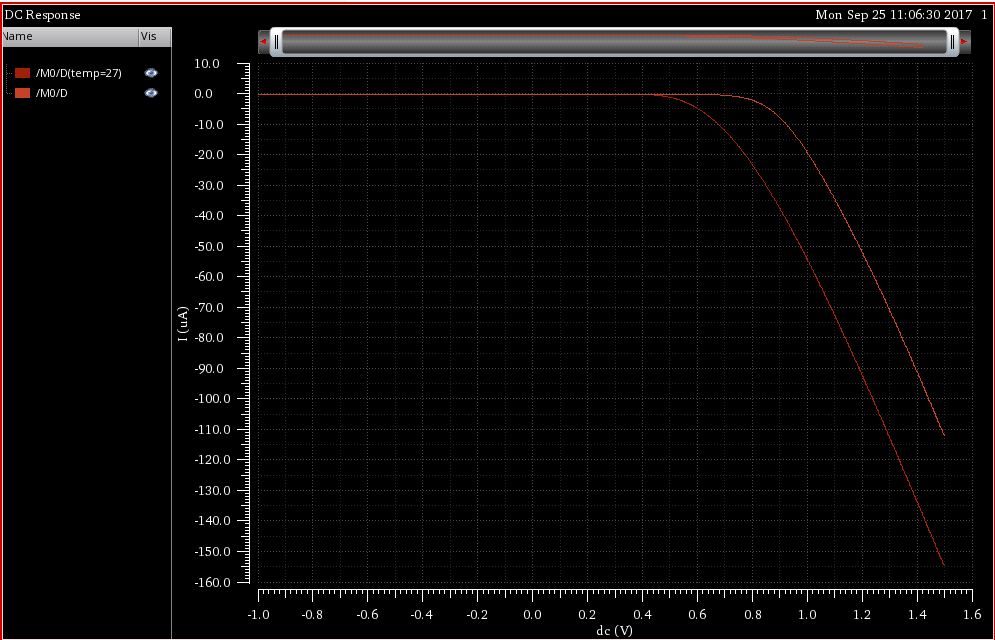
Temperatur effects



*Figur 12 Temperature effect on a PMOS transistor shown with 5 graphs between -40 and 125 degrees, blue line is at -40 degrees and the red line is at 125 degrees*

Again this graph looks different from the Nmos graph, however it shows the same effect and tendencies in increasing the spread around Vt after changing the temperature.

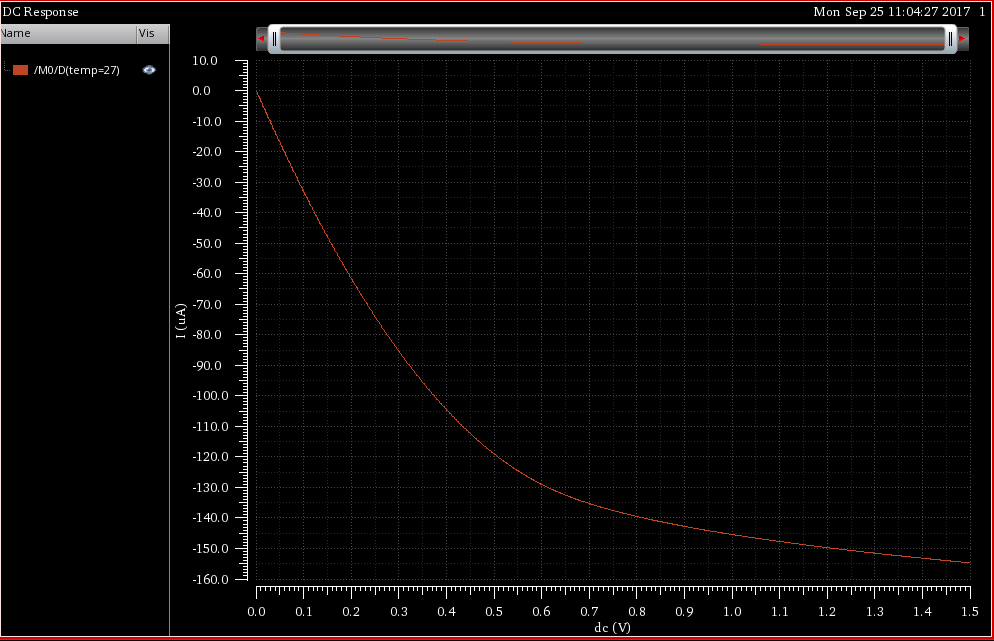
Body voltage effect on threshold voltage



*Figur 13 Threshold voltage increased after the Body is connected to Vdd instead of gnd*

By increasing the body voltage we can manipulate the threshold voltage of the transistor. As seen in Figur 13 the threshold voltage is increased to 800mVcompared to the ~560 we had before, when the bulk gate is connected to Vdd instead of gnd.

Channel length modulation coefficient

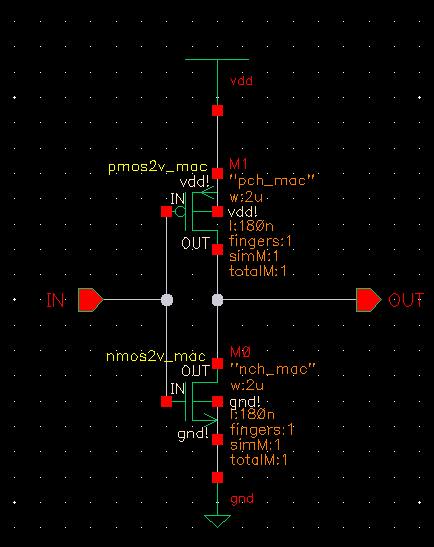


*Figur 14 Graph of the Pmos transistors Ids-Vds characteristics*

To find the Channel length modulation coefficient we follow the equation I\_dsat/R\_on, both of these can be found on the graph. I\_dsat is the current when the transistor enters the saturation region, read as the current when the voltage is at Vt. R\_on is the slope of the linear region after the transistor enters the saturation region. Reading the graph and substituting into our equation we get a Channel length modulation coefficient of: 0.218

* Inverter

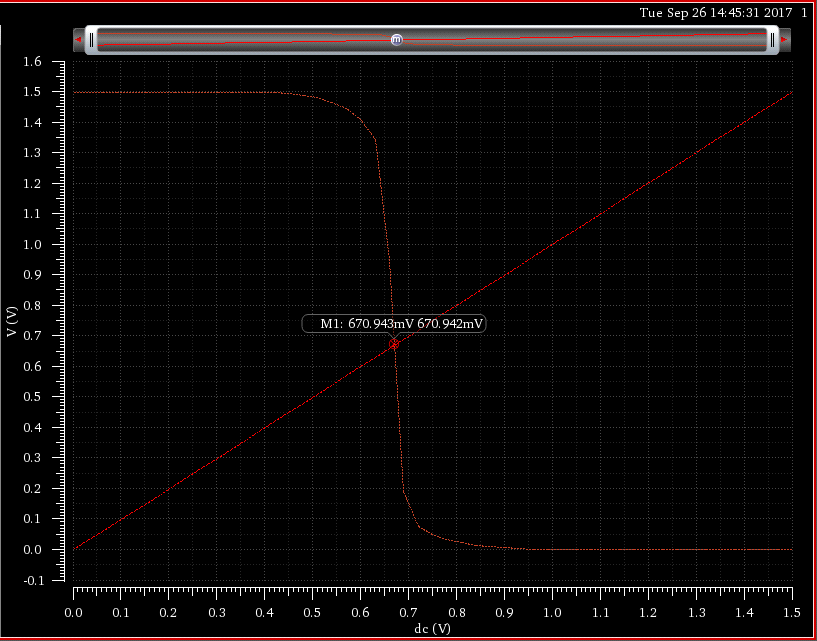
The last part of our assignment is simulating a dc-sweep over a inverter. We have used the following schematic for our inverter



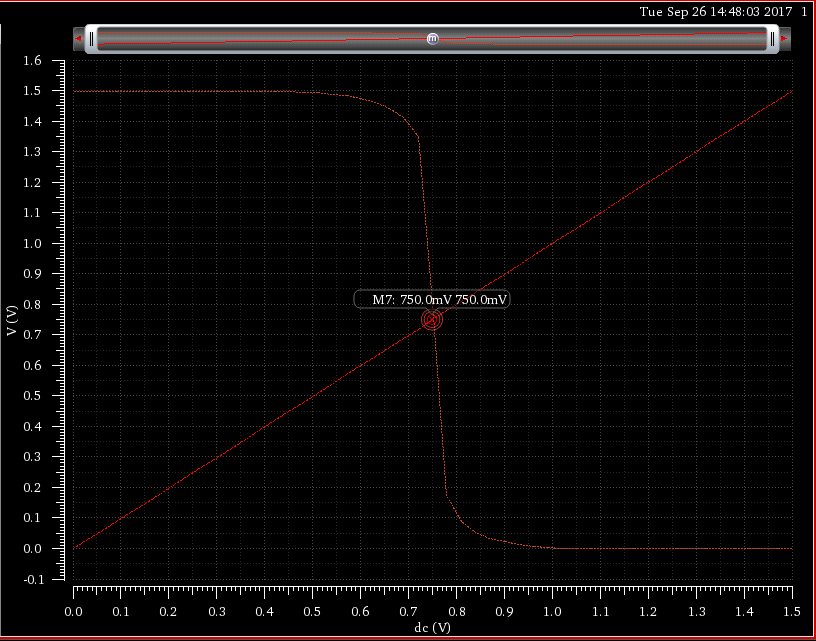
*Figur 15 Schematic of inverter in Virtuoso*

Sizing the transistors

first we have to size the transistors to get the best noise-margin

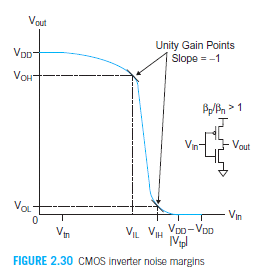


*Figur 16 graph of V(in)/V(out) for inverter without sizing(1 to 1 ratio for transistor width)*



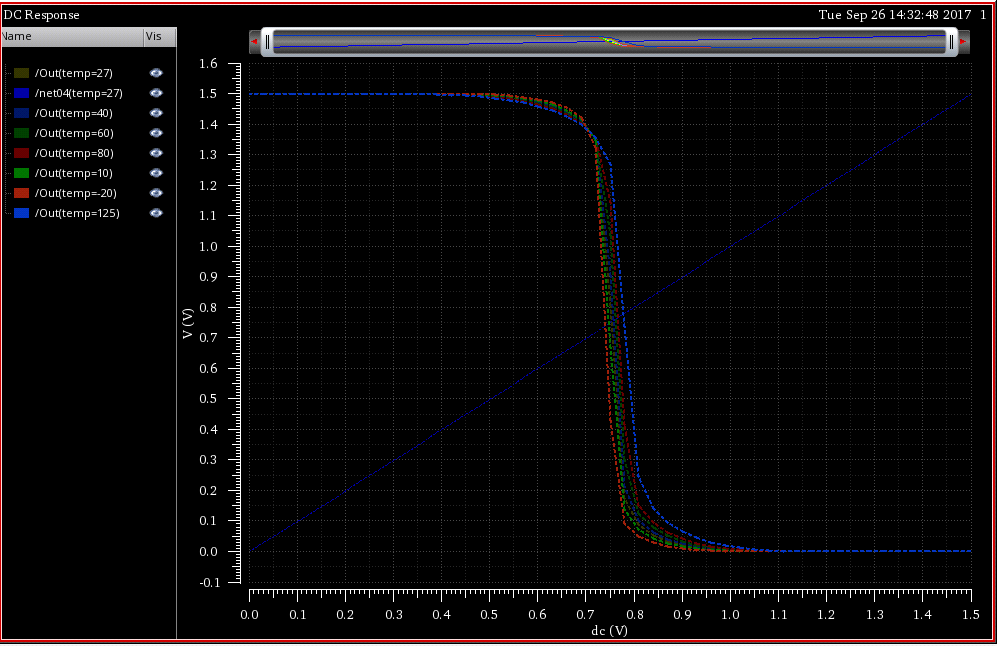
*Figur 17 graph of V(in)/V(out) for inverter with sizing(1 to 3 ratio of transistor width)*

In order to get the best noise margin, we need to have V\_IH and V\_IL(see figure 18) to be closer to eachother. We can see that after resizing the transistors that our graph tends towards this ideal.



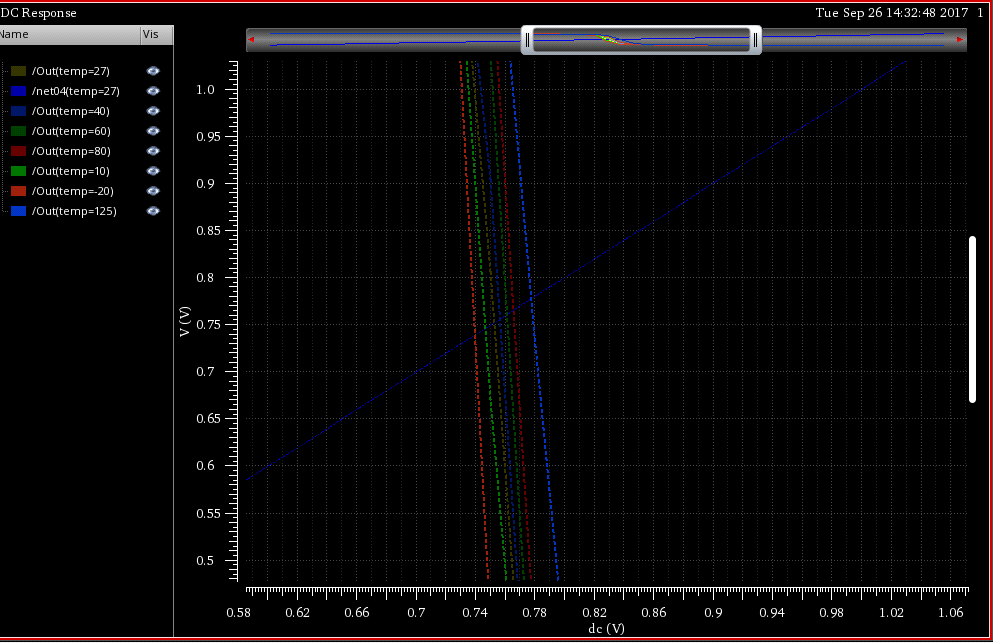
*Figur 17 graph of V(in)/V(out) for CMOS taken from "CMOS VLSI design, page 92)*

Temperature effect on dc-values of inverter



*Figur 18 graph of V(in)/V(out) for inverter the a range of temperatures*

in figur 18 we can see that as the temperature rises the point where the input crosses the output at vdd/2 is moved, this is better seen in figur 19 where we have zoomed in on the region around this point



*Figur 19 zoom in of figur 19 around the VDD/2 point (dark blue line is 27 degrees)*

in figur 19 we can more clearly see that the temperature swings depending on the temperature. The most noticeable difference is that the noisemargin changes with the temperature.